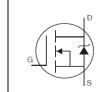




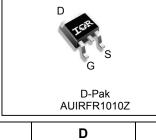
Features

- Advanced Process Technology •
- Low On-Resistance •
- 175°C Operating Temperature
- Fast Switching •
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



HEXFET[®] Power MOSFET

| V _{DSS} | | 55V |
|-----------------------------|---------|-------|
| R _{DS(on)} | typ. | 5.8mΩ |
| | max. | 7.5mΩ |
| I _{D (Silicon Lim} | nited) | 91A |
| I _{D (Package Li} | imited) | 42A |



Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

| | G | |
|------|----------------------|--------|
| | D-Pak AUIRFR1010Z | |
| G | D | S |
| Gate | Drain | Source |

| Bass part number | Dookogo Turo | Standard Pack | | Orderable Part Number |
|------------------|--------------|--------------------|------|-----------------------|
| Base part number | Package Type | Form Quantity | | Orderable Part Number |
| AUIRFR1010Z | D Dek | Tube | 75 | AUIRFR1010Z |
| AUIRFRIUIUZ | D-Pak | Tape and Reel Left | 3000 | AUIRFR1010ZTRL |

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

| Symbol | Parameter | Max. | Units | |
|---|---|-------------------------|-------|--|
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) | 91 | | |
| I _D @ T _C = 100°C | Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) | 65 | _ | |
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10V (Package Limited) | 42 | A | |
| I _{DM} | Pulsed Drain Current ① | 360 | | |
| P _D @T _C = 25°C | Maximum Power Dissipation | 140 | W | |
| | Linear Derating Factor | 0.9 | W/°C | |
| V _{GS} | Gate-to-Source Voltage | ± 20 | V | |
| E _{AS} | Single Pulse Avalanche Energy (Thermally Limited) 2 | 110 | | |
| E _{AS} (Tested) | Single Pulse Avalanche Energy Tested Value 6 | 220 | mJ | |
| I _{AR} | Avalanche Current ① | See Fig.15,16, 12a, 12b | A | |
| E _{AR} | Repetitive Avalanche Energy S | | mJ | |
| TJ | Operating Junction and | -55 to + 175 | | |
| T _{STG} | Storage Temperature Range | | °C | |
| | Soldering Temperature, for 10 seconds (1.6mm from case) | 300 | | |

Thermal Resistance

| Symbol | Parameter | Тур. | Max. | Units |
|---------------------|-----------------------------------|------|------|-------|
| R _{θJC} | Junction-to-Case ® | | 1.11 | |
| $R_{	ext{	heta}JA}$ | Junction-to-Ambient (PCB Mount) 🗇 | | 50 | °C/W |
| $R_{	ext{	heta}JA}$ | Junction-to-Ambient | | 110 | |

HEXFET® is a registered trademark of Infineon.

*Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|-----------------------------------|--------------------------------------|------|-------|------|------------|--|
| V _{(BR)DSS} | Drain-to-Source Breakdown Voltage | 55 | | | V | V _{GS} = 0V, I _D = 250µA |
| $\Delta V_{(BR)DSS} / \Delta T_J$ | Breakdown Voltage Temp. Coefficient | | 0.051 | | V/°C | Reference to 25°C, $I_D = 1mA$ |
| R _{DS(on)} | Static Drain-to-Source On-Resistance | | 5.8 | 7.5 | mΩ | V _{GS} = 10V, I _D = 42A ③ |
| V _{GS(th)} | Gate Threshold Voltage | 2.0 | | 4.0 | V | $V_{DS} = V_{GS}, I_{D} = 100 \mu A$ |
| gfs | Forward Trans conductance | 31 | | | S | V _{DS} = 25V, I _D = 42A |
| 1 | Drain-to-Source Leakage Current | | | 20 | | V _{DS} = 55 V, V _{GS} = 0V |
| IDSS | Drain-to-Source Leakage Current | | | 250 | μA | V _{DS} = 55V,V _{GS} = 0V,T _J =125°C |
| 1 | Gate-to-Source Forward Leakage | | | 200 | n A | V _{GS} = 20V |
| I _{GSS} | Gate-to-Source Reverse Leakage | | | -200 | nA | V _{GS} = -20V |

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| | Continuous Source Current | ſ | | | | |
|-----------------------|------------------------------|------|------|------|-------|---|
| | Parameter | Min. | Тур. | Max. | Units | Conditions |
| Diode Char | acteristics | | | | | |
| C _{oss eff.} | Effective Output Capacitance | | 560 | | | V_{GS} = 0V, V_{DS} = 0V to 44V ④ |
| C _{oss} | Output Capacitance | | 360 | | | $V_{GS} = 0V, V_{DS} = 44V f = 1.0MHz$ |
| C _{oss} | Output Capacitance | | 1630 | | μr | $V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$ |
| C _{rss} | Reverse Transfer Capacitance | | 250 | | pF | <i>f</i> = 1.0MHz |
| C _{oss} | Output Capacitance | | 470 | | | V _{DS} = 25V |
| C _{iss} | Input Capacitance | | 2840 | | | $V_{GS} = 0V$ |
| L _s | Internal Source Inductance | | 7.5 | | nH | from package and center of die contact |
| L _D | Internal Drain Inductance | | 4.5 | | | Between lead, 6mm (0.25in.) |
| t _f | Fall Time | | 48 | | | V _{GS} = 10V③ |
| t _{d(off)} | Turn-Off Delay Time | | 42 | | ns | $R_G = 7.6\Omega$ |
| t _r | Rise Time | | 76 | | ne | I _D = 42A |
| t _{d(on)} | Turn-On Delay Time | | 17 | | | $V_{DD} = 28V$ |
| Q_{gd} | Gate-to-Drain Charge | | 23 | | | V _{GS} = 10V③ |
| Q_{gs} | Gate-to-Source Charge | | 17 | | nC | $V_{DS} = 44V$ |
| Q _g | Total Gate Charge | | 63 | 95 | | I _D = 42A |

| | i didiletei | | 190. | max. | Onito | Conditions |
|-----------------|---|---|------|------|-------|--|
| I _S | Continuous Source Current (Body Diode) | | | 42 | • | MOSFET symbol showing the |
| I _{SM} | Pulsed Source Current (Body Diode) ① | | | 360 | | integral reverse p-n junction diode. |
| V _{SD} | Diode Forward Voltage | | | 1.3 | V | T _J = 25°C,I _S = 42A,V _{GS} = 0V ③ |
| t _{rr} | Reverse Recovery Time | | 24 | 36 | ns | T _J = 25°C ,I _F = 42A, V _{DD} = 28V |
| Q _{rr} | Reverse Recovery Charge | | 20 | 30 | nC | di/dt = 100A/µs③ |
| t _{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by $L_{S}+L_{D}$) | | | | |

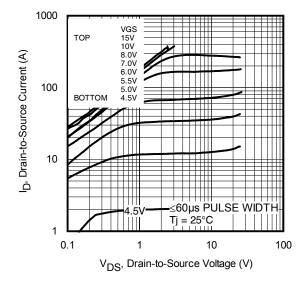
Notes:

 $\odot\;$ Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

② Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 0.13mH, R_G = 25Ω, I_{AS} = 42A, V_{GS} =10V. Part not recommended for use above this value. ③ Pulse width ≤ 1.0ms; duty cycle ≤ 2%.

- ④ Coss eff. is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS
- © Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- © This value determined from sample failure population. 100% tested to this value in production.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- $\label{eq:rescaled} \circledast \ R_{\theta} \text{ is measured at } T_J \text{ approximately } 90^{\circ}\text{C}$





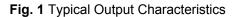


Fig. 2 Typical Output Characteristics

V_{DS}, Drain-to-Source Voltage (V)

-≤60µs PULSE WIDTH Tj = 175°C

100

10

1000

100

10

1

0.1

I_D, Drain-to-Source Current (A)

ТОР

воттом

VGS 15V 10V 8.0V 7.0V 6.0V 5.5V 5.0V 4.5V

1

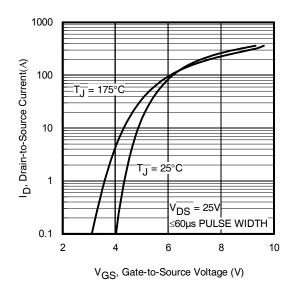


Fig. 3 Typical Transfer Characteristics

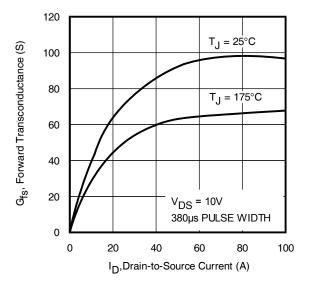
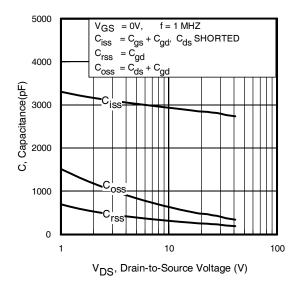
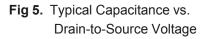


Fig. 4 Typical Forward Trans conductance Vs. Drain Current







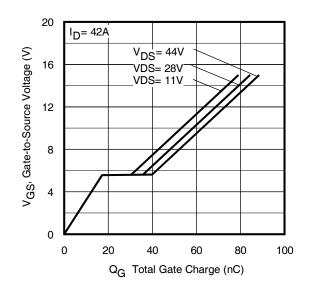
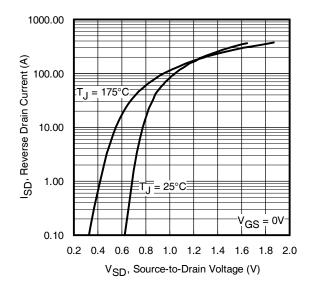
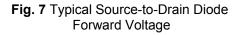


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage





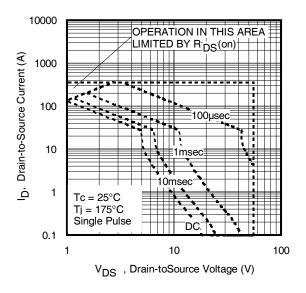


Fig 8. Maximum Safe Operating Area



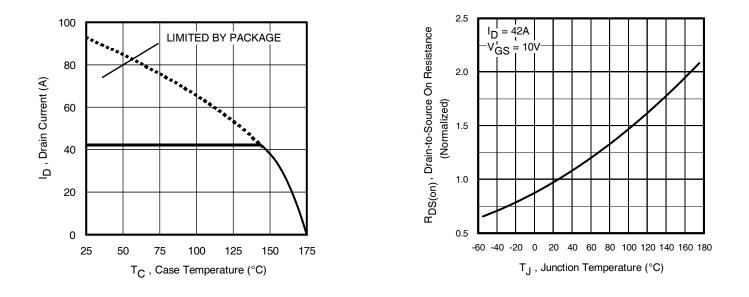


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10. Normalized On-Resistance Vs. Temperature

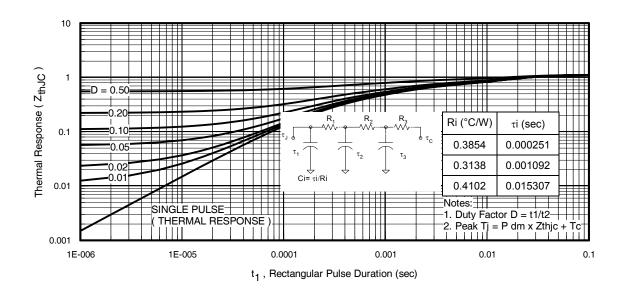


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

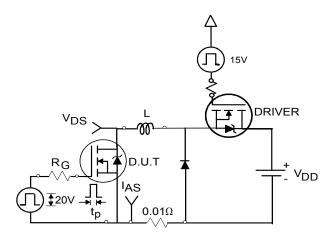


Fig 12a. Unclamped Inductive Test Circuit

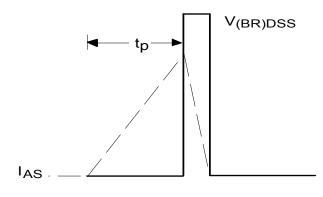


Fig 12b. Unclamped Inductive Waveforms

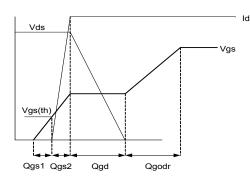


Fig 13a. Gate Charge Waveform

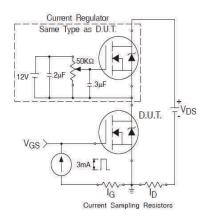


Fig 13b. Gate Charge Test Circuit

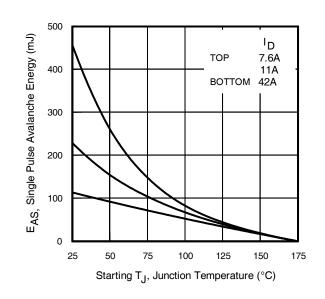


Fig 12c. Maximum Avalanche Energy vs. Drain Current

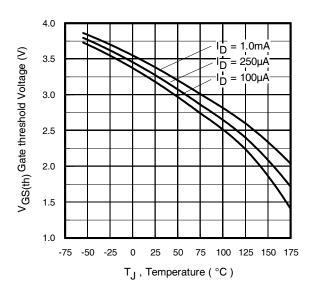


Fig 14. Threshold Voltage Vs. Temperature



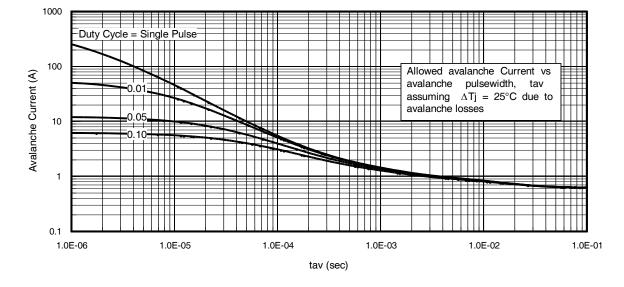
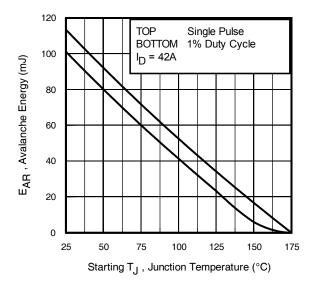
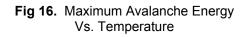


Fig 15. Typical Avalanche Current Vs. Pulse width





Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \textbf{P}_{D (ave)} &= 1/2 \; (\; 1.3 \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T / \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \; \textbf{[} 1.3 \cdot \textbf{BV} \cdot \textbf{Z}_{th} \textbf{]} \\ \textbf{E}_{AS (AR)} &= \textbf{P}_{D (ave)} \cdot \textbf{t}_{av} \end{split}$$



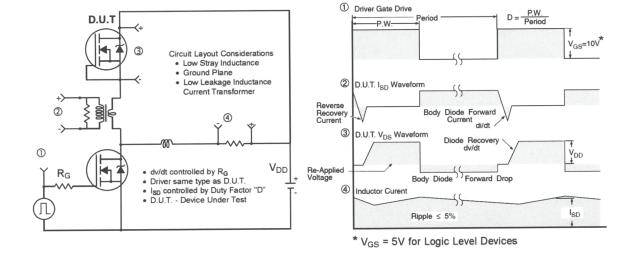


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

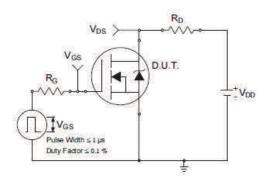


Fig 18a. Switching Time Test Circuit

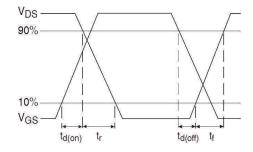
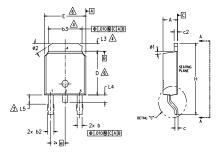


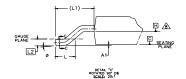
Fig 18b. Switching Time Waveforms

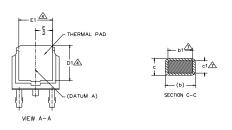


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ▲ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

| S Y M | | | N O T | | | | |
|-------------|--------|-------------|-------------|-------------|---|--|--|
| B | MILLIM | ETERS | INC | INCHES | | | |
| 0 L | MIN. | MAX. | MIN. | MAX. | Ê | | |
| А | 2.18 | 2.39 | .086 | .094 | | | |
| A1 | - | 0.13 | - | .005 | | | |
| b | 0.64 | 0.89 | .025 | .035 | | | |
| b1 | 0.65 | 0.79 | .025 | .031 | 7 | | |
| b2 | 0.76 | 1.14 | .030 | .045 | | | |
| b3 | 4.95 | 5.46 | .195 | .215 | 4 | | |
| с | 0.46 | 0.61 | .018 | .024 | | | |
| c1 | 0.41 | 0.56 | .016 | .022 | 7 | | |
| c2 | 0.46 | 0.89 | .018 | .035 | | | |
| D | 5.97 | 6.22 | .235 | .245 | 6 | | |
| D1 | 5.21 | - | .205 | - | 4 | | |
| Е | 6.35 | 6.73 | .250 | .265 | 6 | | |
| E1 | 4.32 | - | .170 | - | 4 | | |
| е | 2.29 | BSC | .090 | BSC | | | |
| н | 9.40 | 10.41 | .370 | .410 | | | |
| L | 1.40 | 1.78 | .055 | .070 | | | |
| L1 | 2.74 | BSC | .108 | REF. | | | |
| L2 | 0.51 | BSC | .020 | BSC | | | |
| L3 | 0.89 | 1.27 | .035 | .050 | 4 | | |
| L4 | - | 1.02 | - | .040 | | | |
| L5 | 1.14 | 1.52 | .045 | .060 | 3 | | |
| ø | 0. | 10' | 0. | 10 ° | | | |
| ø1 | 0. | 15 ° | 0. | 15* | | | |
| ø2 | 25' | 35* | 25* | 35* | | | |

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

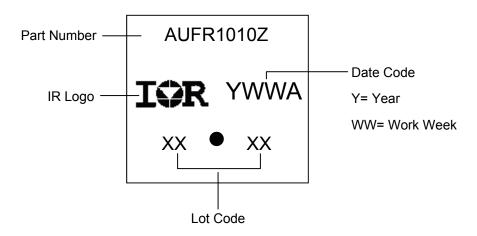
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

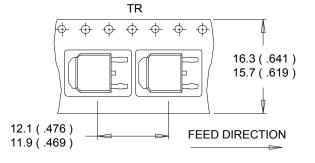
4.- COLLECTOR

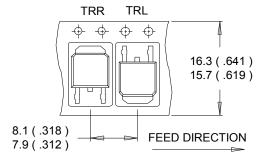
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

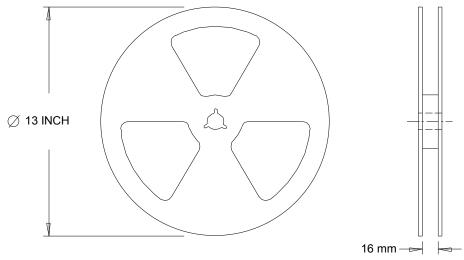
D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES : 1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

| | | (per AEC-Q101) | | | | |
|----------------------|---------------------|--|------------------------------------|--|--|--|
| | | is part number(s) passed Automotive qualification. Infineon's consumer qualification level is granted by extension of the higher el. | | | | |
| Moisture | Sensitivity Level | D-Pak MSL1 | | | | |
| | | | Class M4 (+/- 700V) [†] | | | |
| | Machine Model | AEC-Q101-002 | | | | |
| | Liver on Dedu Medel | | Class H1C (+/- 1500V) [†] | | | |
| ESD | Human Body Model | AEC-Q101-001 | | | | |
| Charged Device Model | | Class C5 (+/- 2000V) [†] | | | | |
| | | AEC-Q101-005 | | | | |
| RoHS Cor | npliant | nt Yes | | | | |

† Highest passing voltage.

Revision History

| Date | Comments | | | |
|------------|---|--|--|--|
| 11/19/2015 | Updated datasheet with corporate template Corrected ordering table on page 1. Corrected RthJA (PCB mount) typo from "40°C/W" to "50°C/W" on page 1. | | | |

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